

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10674017	BAEK ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Talbot, Brian K	1715

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
427	58,282,356,428.01	11/17/06	B. Talbot
updated	search	5/1/07	B. Talbot
updated	search	10/3/07	B. Talbot
updated	search	4/16/08	B. Talbot
updated	search	10/24/08	B. Talbot
updated	search	6/1/09	B. Talbot
updated	search	12/3/09	B. Talbot
updated	search	5/18/10	B. Talbot
updated	search	11/5/10	B. Talbot
updated	search	03/29/11	B. Talbot
updated	search	7/18/11	B. Talbot

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
inventorship search in eDan	10/24/08	B. Talbot
East Search	12/3/09	B. Talbot
east search	3/29/11	B. Talbot

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/Brian K Talbot/ Primary Examiner.Art Unit 1715
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